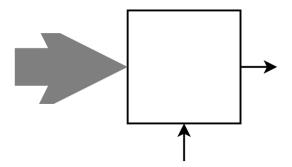
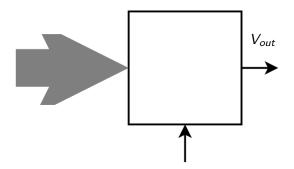
Electronics A to D and D to A Converters

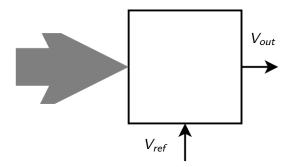
Terry Sturtevant

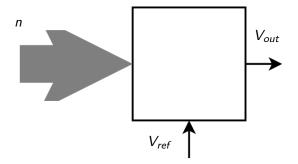
Wilfrid Laurier University

June 24, 2015

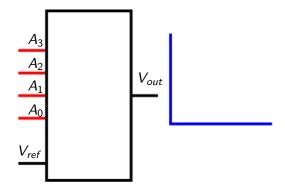


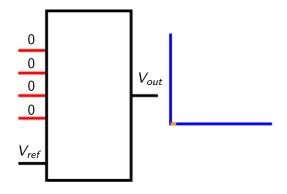


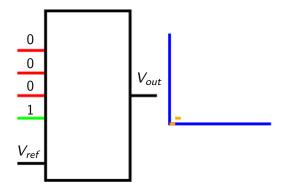


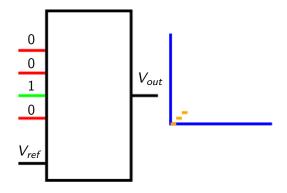


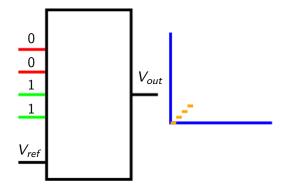
Black box model Features Parameters

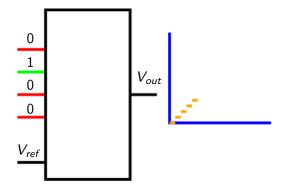


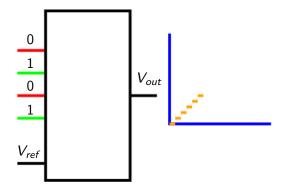


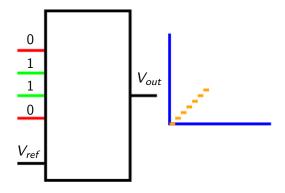


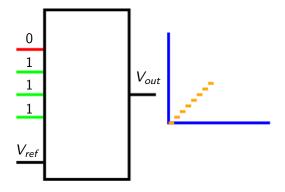


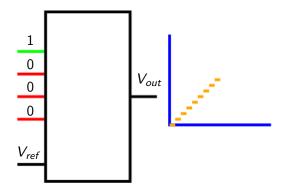


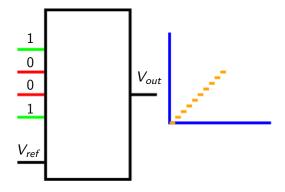


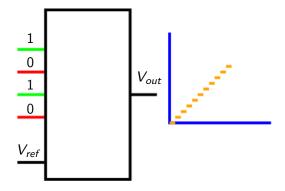


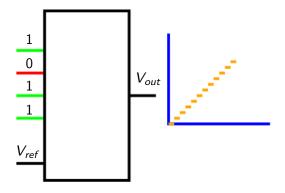


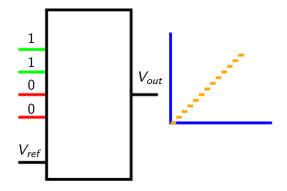


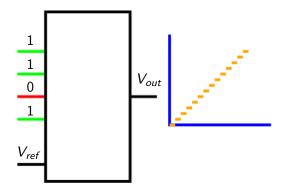


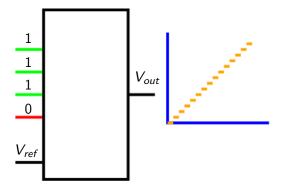


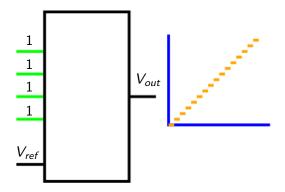












Black box model Features Parameters

digital inputs (N)

- digital inputs (N)
- analog reference

- digital inputs (N)
- analog reference
- analog output, (single or complementary)

- digital inputs (N)
- analog reference
- analog output, (single or complementary)
- $V_{out} = n \quad \frac{V_{ref}}{2^N}$, where $n \in [0, 2^N 1]$

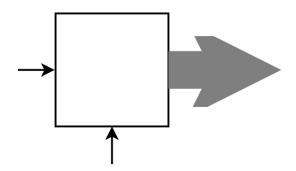
resolution

- resolution
- settling time

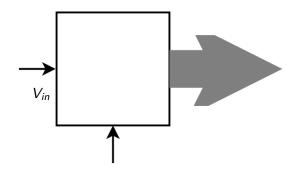
- resolution
- settling time
- buffered inputs

- resolution
- settling time
- buffered inputs
- power supply sensitivity

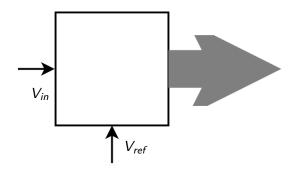
Analog to Digital Converter



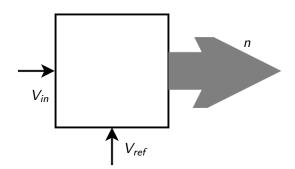
Analog to Digital Converter



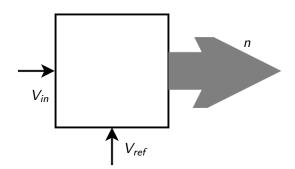
Analog to Digital Converter

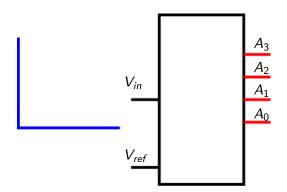


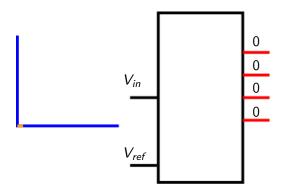
Analog to Digital Converter

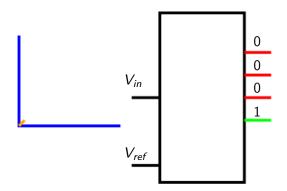


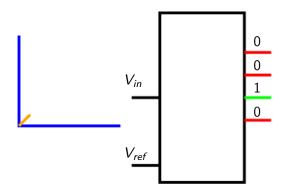
Analog to Digital Converter

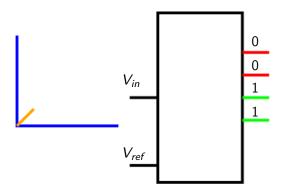


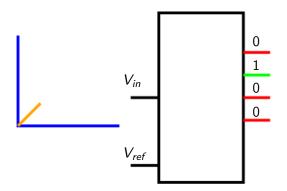


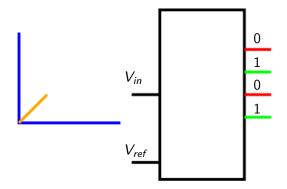


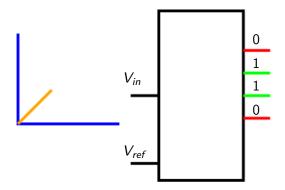


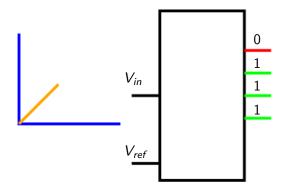


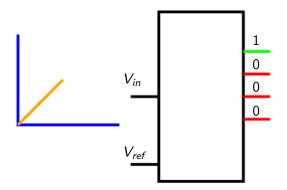


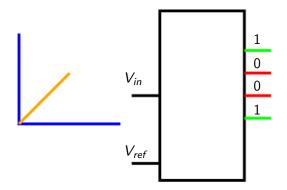


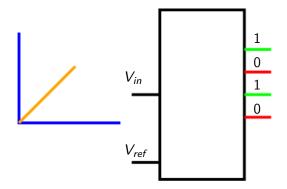


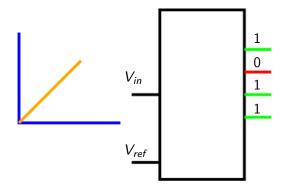


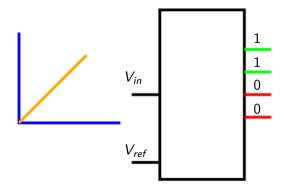


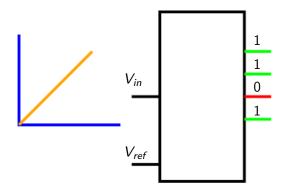


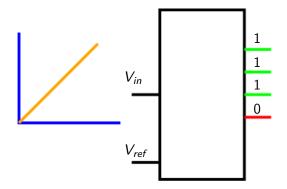


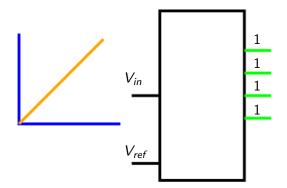












• analog input, (single or differential)

- analog input, (single or differential)
- analog reference

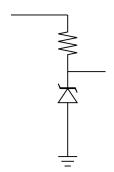
- analog input, (single or differential)
- analog reference
- digital outputs (N)

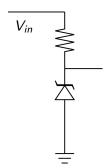
- analog input, (single or differential)
- analog reference
- digital outputs (N)
- $n = \|2^N \frac{V_{in}}{V_{ref}}\|$, where $n \in [0, 2^N 1]$

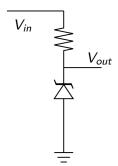
resolution

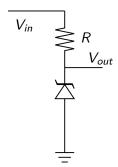
- resolution
- conversion time

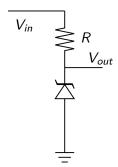
- resolution
- conversion time
- tri-state outputs











Zener voltage

- Zener voltage
- required current

- Zener voltage
- required current
- temperature sensitivity

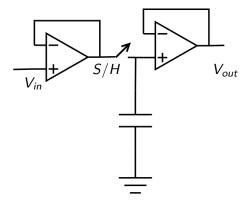
- Zener voltage
- required current
- temperature sensitivity
- variation with current (ac resistance)

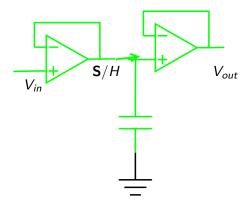
In the "digital world", signals change quickly and in large jumps.

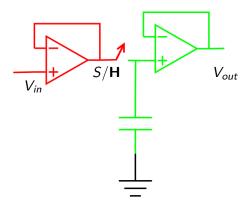
In the "digital world", signals change quickly and in large jumps. In the "analog world", usually signals change more slowly and continuously.

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analog input

- analog input
- analog output

- analog input
- analog output
- digital sample/hold signal

• acquisition time ($\propto C$)

- acquisition time ($\propto C$)
- droop ($\propto 1/C$)

- acquisition time ($\propto C$)
- droop ($\propto 1/C$)

Combining these two indicates a trade-off.

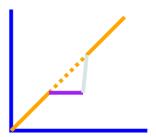
with ADC

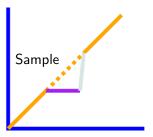
with ADC

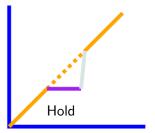
to maintain steady input during conversion

- with ADC to maintain steady input during conversion
- with DAC

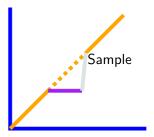
- with ADC
 to maintain steady input during conversion
- with DAC
 to prevent glitches when several input bits change at once

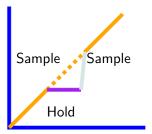






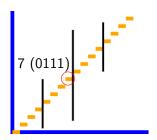
Conversion happens now



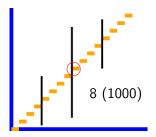


DAC

DAC



DAC

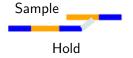




Black box model Parameters Usage







A glitch occuring now won't matter

